



10V/5V Low Dropout Dual Regulator with ENABLE

Description

The CS8147 is a 10V/5V dual output linear regulator. The $10V \pm .5\%$ output sources 500mA and the $5V \pm 3\%$ output sources 70mA. The secondary output is inherently stable and does not require an external capacitor.

The on board ENABLE function controls the regulator's two outputs. When ENABLE is high, the regulator is placed in SLEEP mode. Both outputs are disabled and the

regulator draws only $70\mu A$ of quiescent current.

The regulator is protected against overvoltage conditions. Both outputs are protected against short circuit and thermal runaway conditions.

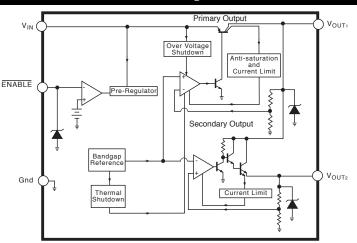
The CS8147 is packaged in a 5 lead TO-220 with copper tab. The copper tab can be connected to a heat sink if necessary.

Absolute Maximum Ratings

Input Voltage (V _{IN})	
DC	18V to 26V
Positive Peak Transient Voltage (46V Load Dump @ $V_{IN} = 14V$)	
$(46V \text{ Load Dump } @ V_{IN} = 14V) \dots$	60V
Negative Peak Transient Voltage	50V
ESD (Human Body Model)	
ENABLE Input	0.3 to 10V
Internal Power Dissipation	Internally Limited
Junction Temperature Range	40°C to +150°C
Storage Temperature Range	65°C to +150°C
Lead Temperature Soldering	
	40 04000 1

Wave Solder (through hole styles only).......10 sec. max, 260°C peak

Block Diagram



Features

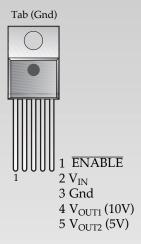
- Two Regulated Outputs $10V \pm 5\%$; 500 mA $5V \pm 3\%$; 70 mA
- 70μA SLEEP Mode Current
- Inherently Stable
 Secondary Output
 (No Output Capacitor
 Required)
- Fault Protection

Overvoltage Shutdown Reverse Battery 60V Peak Transient -50V Reverse Transient Short Circuit Thermal Shutdown

CMOS Compatible ENABLE Input with Low (I_{OUT(max)}) Input Current.

Package Options

5 Lead TO-220





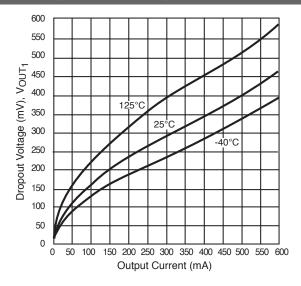
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Electrical Characteristics for V_{OUT} : V_{IN} = 14V, I_{OUT1} = I_{OUT2} = 5mA, -40°C < T_J < 150°C, -40°C ≤ T_A ≤ 125°C, \overline{ENABLE} = LOW; unless otherwise specified.

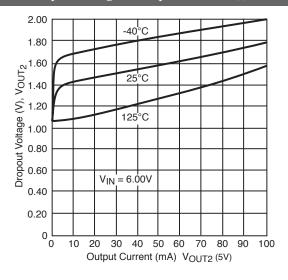
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
■ Primary Output (V _{OUT1})					
Output Voltage	$13V \le V_{IN} \le 26V, I_{OUT1} \le 500 \text{mA},$ 9.50		10.00	10.50	
Dropout Voltage	$I_{OUT1} = 500 \text{mA}$		0.5	0.7	V
Line Regulation	$11V \le V_{IN} \le 18V$, $I_{OUT1} = 250mA$		45	90	mV
Load Regulation	$5mA \le I_{OUT1} \le 500mA$		15	75	mV
Quiescent Current	$I_{OUT1} \le 1$ mA, No Load on V_{OUT2} , $V_{IN} = 18$ $I_{OUT1} = 500$ mA, No Load on V_{OUT2} , $V_{IN} =$		3 60	7 120	mA mA
Quiescent Current	$ \overline{ENABLE} = HIGH V_{OUT1}, V_{OUT2} = OFF $		70	200	μΑ
Current Limit	0.55		0.80		A
Long Term Stability			50		mV/khr
Over Voltage Shutdown	V _{OUT1} and V _{OUT2}	32	36	40	V
■ Secondary Output (V _{OUT2})					
Output Voltage	$6V \le V_{IN} \le 26V$, $1mA \le I_{OUT2} \le 70mA$ 4.8		5.00	5.15	V
Dropout Voltage	$I_{OUT2} \le 70 \text{mA}$		1.5	2.5	V
Line Regulation	$11 \le V_{IN} \le 18V$, $I_{OUT} = 70\mu A$		4	50	mV
Load Regulation	$1\text{mA} \le I_{OUT2} \le 70\text{mA}, V_{IN} = 14\text{V}$		10	50	mV
Current Limit		-	150		mA
■ ENABLE Function (ENABLE)					
Input ENABLE Threshold	V _{OUT2(ON)}		1.40	2.50	V
	V _{OUT1(OFF)}	.8	1.40		V
Input ENABLE Current	Input Voltage Range 0 to 5V	-10		10	μΑ

Package Lead Description			
PACKAGE LEAD #	LEAD SYMBOL	FUNCTION	
5 Lead TO-220			
1	ENABLE	CMOS compatible input lead; switches V_{OUT1} and V_{OUT2} on and off. When \overline{ENABLE} is low, V_{OUT1} and V_{OUT2} are active.	
2	V_{IN}	Supply voltage, usually direct from battery.	
3	Gnd	Ground connection.	
4	V_{OUT1}	Regulated output 10V, 500mA (typ)	
5	$V_{\rm OUT2}$	Secondary output 5V, 70mA (typ).	

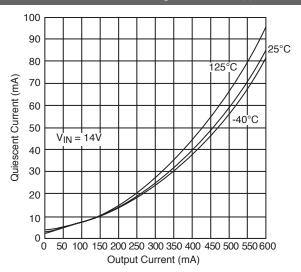
Dropout Voltage vs. Output Current (V_{OUT1})



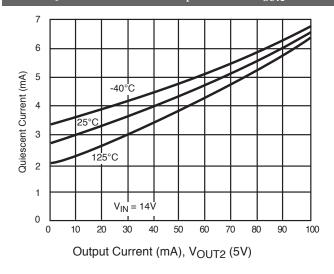
Dropout Voltage vs. Output Current (VOUT2)



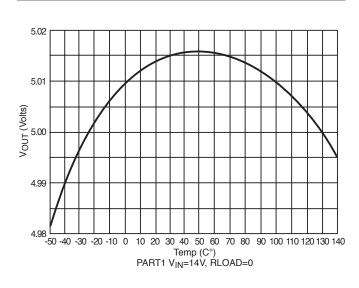
Quiescent Current vs. Output Current (VOUT1)



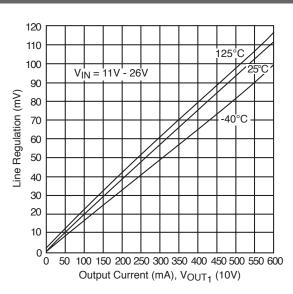
Quiescent Current vs. Output Current (VOUT2)



V_{OUT2} vs. Temperature

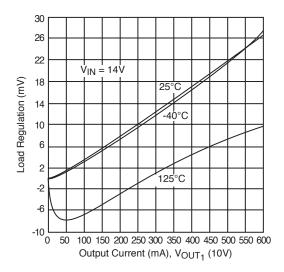


Line Regulation vs. Output Current (V_{OUT1})

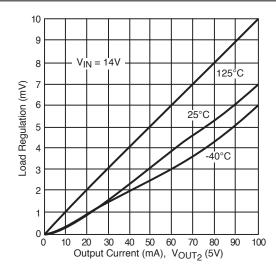


Typical Performance Characteristics

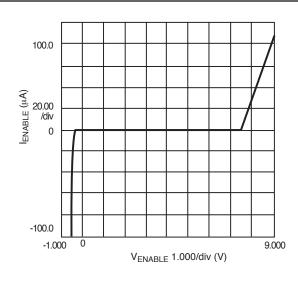
Load Regulation vs. Output Current (V_{OUT1})



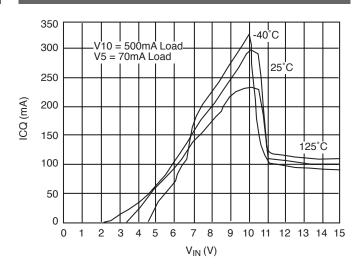
Load Regulation vs. Output Current (VOUT2)



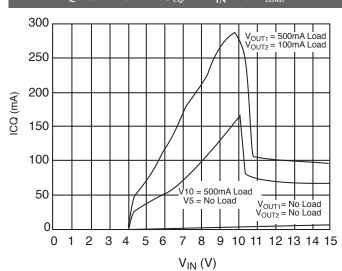
ENABLE Input Current vs. Input Voltage



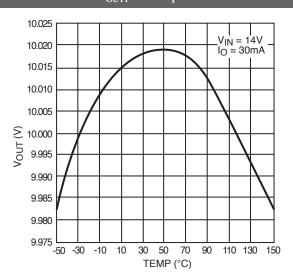
Quiescent Current (I_{CQ}) vs. V_{IN} over Temperature



Quiescent Current (I_{CQ}) vs. V_{IN} over R_{LOAD}



V_{OUT1} vs. Temperature



Definition of Terms

Dropout Voltage: The input-output voltage differential at which the circuit ceases to regulate against further reduction in input voltage. Measured when the output voltage has dropped 100mV from the nominal value obtained at 14V input, dropout voltage is dependent upon load current and junction temperature.

Current Limit: Peak current that can be delivered to the output.

Input Voltage: The DC voltage applied to the input terminals with respect to ground.

Input Output Differential: The voltage difference between the unregulated input voltage and the regulated output voltage for which the regulator will operate.

Line Regulation: The change in output voltage for a change in the input voltage. The measurement is made under conditions of low dissipation or by using pulse techniques such that the average chip temperature is not significantly affected. **Load Regulation:** The change in output voltage for a change in load current at constant chip temperature.

Long Term Stability: Output voltage stability under accelerated life-test conditions after 1000 hours with maximum rated voltage and junction temperature.

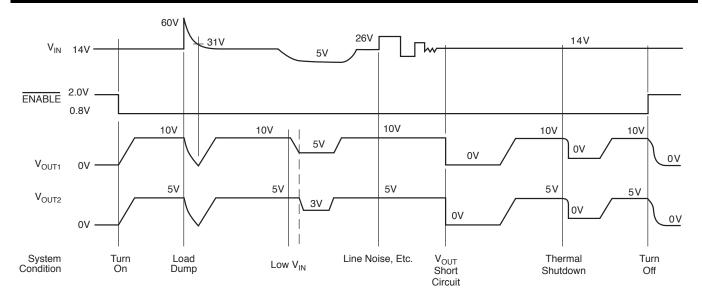
Output Noise Voltage: The rms AC voltage at the output, with constant load and no input ripple, measured over a specified frequency range.

Quiescent Current: The part of the positive input current that does not contribute to the positive load current. The regulator ground lead current.

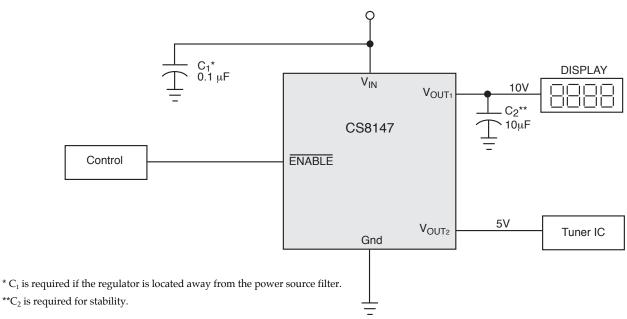
Ripple Rejection: The ratio of the peak-to-peak input ripple voltage to the peak-to-peak output ripple voltage.

Temperature Stability of V_{OUT}: The percentage change in output voltage for a thermal variation from room temperature to either temperature extreme.

Typical Circuit Waveform



Test & Applications Circuit



Since both outputs are controlled by the same ENABLE, the CS8147 is ideal for applications where a sleep mode is required. Using the CS8147, a section of circuitry such as a display and nonessential 5V circuits can be shut down under microprocessor control to conserve energy.

The test applications circuit diagram shows an automotive radio application where the display is powered by 10V from V_{OUT1} and the Tuner IC is powered by 5V from V_{OUT2} . Neither output is required unless both the ignition and the Radio On/OFF switch are on.

Stability Considerations

The secondary output V_{OUT2} is inherently stable and does not require a compensation capacitor. However a compensation capacitor connected between V_{OUT1} and ground is required for stability in most applications.

The output or compensation capacitor helps determine three main characteristics of a linear regulator: start-up delay, load transient response and loop stability.

The capacitor value and type should be based on cost, availability, size and temperature constraints. A tantalum or aluminum electrolytic capacitor is best, since a film or ceramic capacitor with almost zero ESR can cause instability. The aluminum electrolytic capacitor is the least expensive solution, but, if the circuit operates at low temperatures (-25°C to -40°C), both the value and ESR of the capacitor will vary considerably. The capacitor manufacturers data sheet usually provides this information.

The value for the output capacitor C2 shown in the test and applications circuit should work for most applications, however it is not necessarily the optimized solution.

To determine acceptable value for C2 for a particular application, start with a tantalum capacitor of the recommended value and work towards a less expensive alternative part.

Step 1: Place the completed circuit with a tantalum capacitor of the recommended value in an environmental chamber at the lowest specified operating temperature and monitor the outputs with an oscilloscope. A decade box connected in series with the capacitor will simulate the higher ESR of an aluminum capacitor. Leave the decade box outside the chamber, the small resistance added by the longer leads is negligible.

Step 2: With the input voltage at its maximum value, increase the load current slowly from zero to full load while observing the output for any oscillations. If no oscillations are observed, the capacitor is large enough to ensure a stable design under steady state conditions.

Step 3: Increase the ESR of the capacitor from zero using the decade box and vary the load current until oscillations appear. Record the values of load current and ESR that cause the greatest oscillation. This represents the worst case load conditions for the regulator at low temperature.

Step 4: Maintain the worst case load conditions set in step 3 and vary the input voltage until the oscillations increase. This point represents the worst case input voltage conditions.

Step 5: If the capacitor is adequate, repeat steps 3 and 4 with the next smaller valued capacitor. A smaller capacitor will usually cost less and occupy less board space. If the output oscillates within the range of expected operating conditions, repeat steps 3 and 4 with the next larger standard capacitor value.

Step 6: Test the load transient response by switching in various loads at several frequencies to simulate its real working environment. Vary the ESR to reduce ringing.

Step 7: Raise the temperature to the highest specified operating temperature. Vary the load current as instructed in step 5 to test for any oscillations.

Once the minimum capacitor value with the maximum ESR is found for each output, a safety factor should be added to allow for the tolerance of the capacitor and any variations in regulator performance. Most good quality aluminum electrolytic capacitors have a tolerance of $\pm 20\%$ so the minimum value found should be increased by at least 50% to allow for this tolerance plus the variation which will occur at low temperatures. The ESR of the capacitors should be less than 50% of the maximum allowable ESR found in step 3 above.

Calculating Power Dissipation in a Dual Output Linear Regulator

The maximum power dissipation for a dual output regulator (Figure 1) is

$$\begin{split} P_{D(max)} &= \{V_{IN(max)} - V_{OUT1(min)}\}I_{OUT1(max)} + \\ &\{V_{IN(max)} - V_{OUT2(min)}\}I_{OUT2(max)} + V_{IN(max)}IQ \end{split} \tag{1}$$

Where:

V_{IN(max)} is the maximum input voltage,

 $V_{OUT1(min)}$ is the minimum output voltage from V_{OUT1} ,

V_{OUT2(min)} is the minimum output voltage from V_{OUT2},

 $I_{OUT1(max)}$ is the maximum output current, for the application,

 $I_{OUT2(max)}$ is the maximum output current, for the application, and

 I_Q is the quiescent current the regulator consumes at $I_{OUT(max)}.$

Once the value of $P_{D(max)}$ is known, the maximum permissible value of $R_{\Theta JA}$ can be calculated:

$$R_{\Theta JA} = \frac{150^{\circ} \text{C} - \text{T}_{A}}{P_{D}} \tag{2}$$

The value of $R_{\Theta JA}$ can then be compared with those in the package section of the data sheet. Those packages with $R_{\Theta JA}$'s less than the calculated value in equation 2 will keep the die temperature below 150°C.

In some cases, none of the packages will be sufficient to dissipate the heat generated by the IC, and an external heatsink will be required.

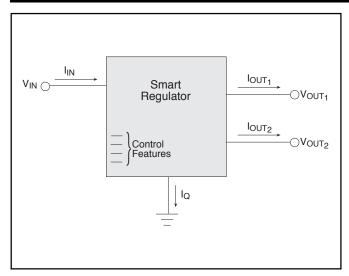


Figure 1: Dual output regulator with key performance parameters labeled.

Heat Sinks

A heat sink effectively increases the surface area of the package to improve the flow of heat away from the IC and into the surrounding air.

Each material in the heat flow path between the IC and the outside environment will have a thermal resistance. Like series electrical resistances, these resistances are summed to determine the value of $R_{\Theta JA}\colon$

$$R_{\Theta JA} = R_{\Theta JC} + R_{\Theta CS} + R_{\Theta SA} \tag{3}$$

where:

 $R_{\Theta IC}$ = the junction–to–case thermal resistance,

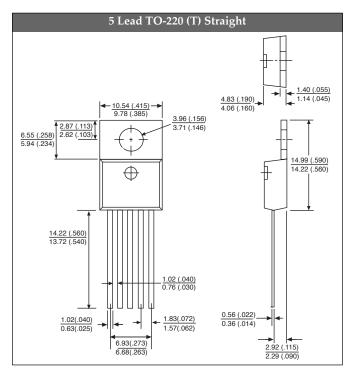
 $R_{\Theta CS}$ = the case–to–heatsink thermal resistance, and

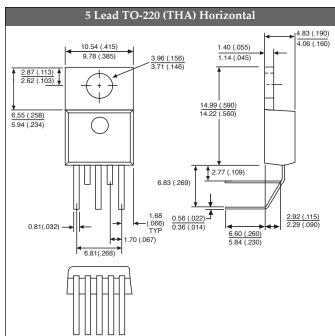
 $R_{\Theta SA}$ = the heatsink–to–ambient thermal resistance.

 $R_{\Theta|C}$ appears in the package section of the data sheet. Like $R_{\Theta|A}$, it too is a function of package type. $R_{\Theta CS}$ and $R_{\Theta SA}$ are functions of the package type, heatsink and the interface between them. These values appear in heat sink data sheets of heat sink manufacturers.

Package Specification

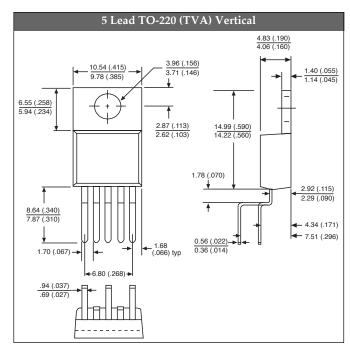
PACKAGE DIMENSIONS IN MM (INCHES)





PACKAGE THERMAL DATA

Therma	1 Data	5 Lead TO-220	
$R_{\Theta JC}$	typ	2.4	°C/W
$R_{\Theta JA}$	typ	50	°C/W



Ordering Information

Part Number	Description
CS8147YT5	5 Lead TO-220 Straight
CS8147YTVA5	5 Lead TO-220 Vertical
CS8147YTHA5	5 Lead TO-220 Horizontal

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